

View Online at <https://aerobasegroup.com/nsn/5910-01-447-1532>

Body Style:

Chip type

Reliability Indicator:

Established

Reliability Failure Rate Level In Percent:

0.100

Body Length:

0.138 inches

Body Width:

0.083 inches

Body Height:

0.110 inches

Schematic Diagram Designator:

No common or grounded electrode (s)

Electrical Polarization:

Polarized

Capacitance Value Per Section:

2.200 microfarads single section

Nonderated Operating Temp:

Between -55.0 degrees celsius and 85.0 degrees celsius

Nonderated Continuous Voltage Rating And Type Per Section:

10.0 dc single section

Tolerance Range Per Section:

-10.00/+10.00 percent single section

Case Material:

Ceramic

Capacitive Electrode Material:

Tantalum

Special Features:

Weibull failure rate

Test Data Document:

81349-mil-c-55365 specification (includes engineering type bulletins, brochures, etc., that reflect specification type data in specification format; excludes commercial catalogs, industry directories, and similar trade publications, reflecting general type data on certain environmental and performance requirements and test conditions that are shown as "typical", "average", "", etc.).

Terminal Type And Quantity:

2 bonding pad

Specification Data:

81349-mil-c-55365/8 government specification

Shelf Life:

N/a

Unit Of Measure:

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Demilitarization:

No

Fiig:

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